OFGS File No. P/4178-10 Application 10/700,020 PPLICANT'S ART CITATION Yusuke MURAOKA et al. (Use separal sheets if necessary) Group Art Unit Filing Date JAN 2 6 2004 1734 November 3, 2003 **U.S. PATENT DOCUMENTS** Sub-class Filing Date If Appropriate Date MM-YYYY Class **Document Number** Name 2 YII US-5,700,379 12-1997 Biebl 216 401 US-6,358,673 03-2002 Namatsu 430 311 430 322 US-2002-0132192 A1 09-2002 Namatsu US-2002-0160625 A1 10-2002 Inoue et al. 438 780 40 US-6,554,507 B2 04-2003 Namatsu 396 611 FOREIGN PATENT DOCUMENTS Date MM-YYYY Translation Sub-class Class Document Number Country Yes No 03-1996 411 DE 195 06 404 C1 DE M 8-250464 09-1996 Japan Х EP 0 732 557 A2 09-1996 EP 11-87306 03-1999 Japan 2000-91180 03-2000 Japan X EP 0 992 852 A2 04-2000 EP 2000-138156 05-2000 Japan 08-2000 2000-223467 Japan Х 3343219 08-2002 Japan X 2002-329650 11-2002 JР Х 2003-51475 02-2003 JP Х OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.) AU A Concise Explanation sheet Examiner Prop 01 Date Considered EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.